

# sneak PREVIEW



## SPIE Optics & Photonics – San Diego, CA

**AUGUST 11-13, 2015**

An advance look at the products, trends and technologies being presented.



### Latest Research, Technologies Slated for SPIE Optics + Photonics 2015

SPIE Optics + Photonics 2015, to be held Aug. 9-13 in San Diego, is the largest international, multidisciplinary optical sciences and technology meeting in North America, featuring the latest research in optical engineering and applications, sustainable energy, nanotechnology, organic photonics and astronomical instrumentation. The annual event focuses specifically on advancing nanoscience, optical engineering, organic photonics, and sustainable energy research.

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## Featured Exhibitors

### [Micro-Spectrometers for OEMs](#)

**From: Hamamatsu Corporation**

Micro-spectrometers are composed of a grating chip and CMOS sensor chip enclosed in a compact hermetically sealed package, and are sensitive to 340-780 nm or 340-850 nm wavelengths. Approximately the size of a fingertip, micro-spectrometers are suitable for portable instruments.

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### [Test System for Camera Modules](#)

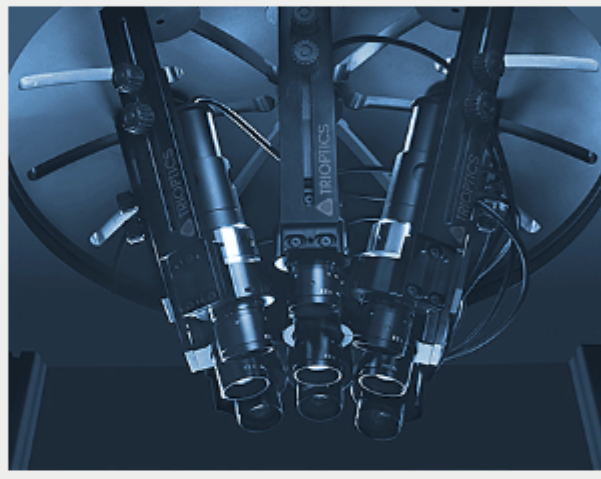
**From: TRIOPTICS GmbH**

The ProCam<sup>®</sup> Test measurement system provides fast and comprehensive quality control for fully assembled camera modules. The modular approach of the ProCam<sup>®</sup> Test system – using different innovative types of illumination – allows conducting a wide range of camera tests related to image resolution, image aberrations, color rendering and sensor properties.

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### [The Exemplar Plus LS Spectrometer](#)

**From: B&W Tek, Inc.**

The Exemplar<sup>®</sup> Plus LS is a smart CCD spectrometer that utilizes an aberration corrected concave holographic grating to minimize stray light. It provides superior data quality over the entire 190-1100nm spectral range with a high quantum efficiency detector.

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### [MicroMate 3:1 Zoom Lens System](#)

**From: Navitar, Inc.**

Designed to work with hi-res 4/3" sensor cameras, the MicroMate modular system images onto a 22.5mm diagonal with no vignetting when combined with Navitar objectives. It can process 4X as much critical data at the camera sensor while maintaining pixel resolution.

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### [IR AFM Imaging at Nanometer-Scale](#)

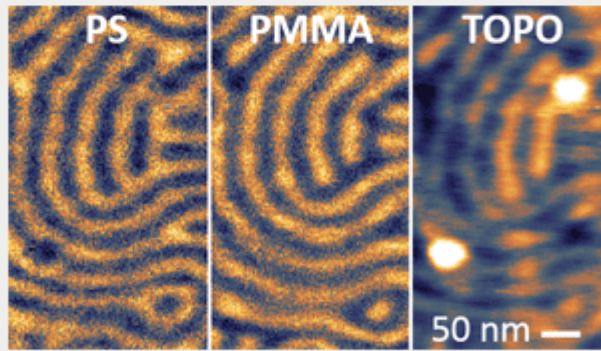
**From: Molecular Vista, Inc.**

VistaScope provides infrared spectral images with topography via photo-induced force microscopy (PIFM). Operated in air, PIFM provides chemical specificity at nm-scale even on samples difficult for electron microscopes, such as polymers (image highlights individual polymeric species and topography in PS-b-PMMA).

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### [FISBA Precision Molded Lenses](#)

**From: FISBA AG**

FISBA is a world-leading supplier of precision molded infrared optics. These products are used in the SWIR to LWIR range. The scalability of the manufacturing process and the resulting lower unit prices open up new possibilities for use in various applications.

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